

	Control	Stressed	% RR
PH (cm)	54.25 ± 2.67	44.09 ± 1.78	18.73
FLA (cm ²)	16.73 ± 1.65	5.28 ± 0.81	68.44
FLDM (g)	0.061 ± 0.002	0.019 ± 0.001	68.85
NCPP	4.14 ± 0.4	1 ± 0.01	75.86
NSPS	24.6 ± 1.21	16.09 ± 1.09	34.65
SDM (g)	0.37 ± 0.002	0.14 ± 0.04	62.16
KNPS	20 ± 1.155	5 ± 0.58	75
KWPS	0.65 ± 0.034	0.15 ± 0.02	76.49

Table 1. Phenotypic analyses on plant groups (control and stressed) of durum wheat grown with different N concentrations. For each parameter, mean values (\pm standard error) and relative reductions between control and stressed conditions are presented. PH: plant height; FLA: flag leaf area; NCPP: number of culms per plant; NSPS: number of spikelets per spike; SDM: spike dry matter; FLDM: flag leaf dry matter; KNPS: kernel number per spike; KWPS: kernel weight per spike; RR: relative reduction.